## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination NAKAYA ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,369,758	04-2002	Zhang, Deming	342/383
*	В	US-6,677,898	01-2004	Cheng et al.	342/372
*	O	US-7,057,573	06-2006	Ohira, Takashi	343/817
*	D	US-6,624,784	09-2003	Yamaguchi, Ryo	342/378
*	E	US-2003/0069047	04-2003	Kitahara, Minako	455/562
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	J	US-			
	κ	US-		·	
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S				>	
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.